TOSHIBA Digital Integrated Circuit Silicon Monolithic

TC7WP3125FK, TC7WP3125FC

Low Voltage/Low Power 2-Bit Dual Supply Bus Buffer

The TC7WP3125 is a dual supply, advanced high-speed CMOS 2-bit dual supply voltage interface bus buffer fabricated with silicon gate CMOS technology.

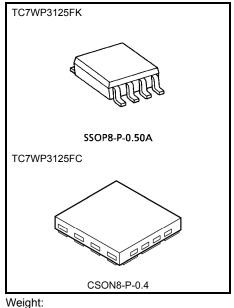
It is also designed with over voltage tolerant inputs and outputs up to $3.6~\mathrm{V}.$

Designed for use as an interface between a 1.2-V, 1.5-V, 1.8-V, or 2.5-V bus and a 1.8-V, 2.5-V or 3.6-V bus in mixed 1.2-V, 1.5-V, 1.8-V or 2.5-V/1.8-V, 2.5-V or 3.6-V supply systems.

The A-input interfaces with the 1.2-V, 1.5-V, 1.8-V or 2.5-V bus, the B-output with the 1.8-V, 2.5-V, 3.3-V bus.

The enable input (\overline{OE}) can be used to disable the device so that the signal lines are effectively isolated.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.



SSOP8-P-0.50A : 0.01 g (typ.) CSON8-P-0.4 : 0.002 g (typ.)

Features

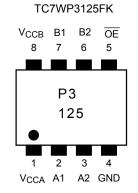
- Level converter for interfacing 1.2-V to 1.8-V, 1.2-V to 2.5-V, 1.2-V to 3.3-V, 1.5-V to 2.5-V, 1.5-V to 3.3-V, 1.8-V to 2.5-V, 1.8-V to 3.3-V or 2.5 V to 3.3-V system.
- High-speed operation : $t_{pd} = 6.8 \text{ ns} (\text{max}) (V_{CCA} = 2.5 \pm 0.2 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V})$
 - $t_{pd} = 7.8 \text{ ns} \text{ (max)} (V_{CCA} = 1.8 \pm 0.15 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V})$

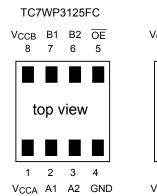
 $t_{pd} = 8.6 \text{ ns} (\text{max}) (\text{V}_{\text{CCA}} = 1.5 \pm 0.1 \text{ V}, \text{V}_{\text{CCB}} = 3.3 \pm 0.3 \text{ V})$

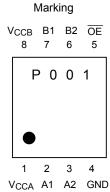
- $t_{pd} = 22 \text{ ns} (max) (V_{CCA} = 1.2 \pm 0.1 \text{ V}, V_{CCB} = 3.3 \pm 0.3 \text{ V})$
- t_{pd} = 9.5 ns (max) (V_{CCA} = 1.8 ± 0.15 V, V_{CCB} = 2.5 ± 0.2 V)
- t_{pd} = 10.8 ns (max) (V_{CCA} = 1.5 \pm 0.15 V, V_{CCB} = 2.5 \pm 0.2 V)
- $t_{pd} = 23 \text{ ns} \text{ (max)} (V_{CCA} = 1.2 \pm 0.15 \text{ V}, V_{CCB} = 2.5 \pm 0.2 \text{ V})$
- t_{pd} = 30 ns (max) (V_{CCA} = 1.2 \pm 0.1 V, V_{CCB} = 1.8 \pm 0.15 V)
- Output current : $I_{OH}/I_{OL} = \pm 12 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$ $I_{OH}/I_{OL} = \pm 9\text{mA (min)} (V_{CC} = 2.3 \text{ V})$
 - $I_{OH}/I_{OL} = \pm 3 \text{ mA} \text{ (min)} (V_{CC} = 1.65 \text{ V})$
- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200 \text{ V}$
 - Human body model $\ge \pm 2000 \text{ V}$
 - Ultra-small package: CSON8(CST8), SSOP8(US8)
- Low current consumption: Using the new circuit significantly reduces current consumption when $\overline{OE} = "H"$. Suitable for battery-driven applications such as PDAs and cellular phones.
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs.

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

Pin Assignment (top view)







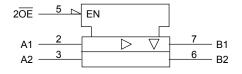
Truth Table

Inputs		Output
OE	A1, A2	B1, B2
L	L	L
L	Н	н
Н	Х	Z

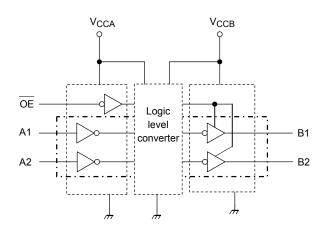
X: Don't care

Z: High impedance

IEC Logic Symbol



Block Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit	
Power supply voltage (Note 2)	V _{CCA}	–0.5 to 4.6	V	
(Note 2)	V _{CCB}	–0.5 to 4.6	v	
DC input voltage (An, OE)	VIN	–0.5 to 4.6	V	
DC output voltage	\/	-0.5 to 4.6 (Note 3)	V	
(Bn)	VOUTB	-0.5 to V_{CCB} + 0.5 (Note 4)	v	
Input diode current	liк	-50	mA	
Output diode current	lok	±50 (Note 5)	mA	
DC output current	IOUTB	±25	mA	
DC V _{CC} /ground current per supply pin	ICCA	±25	mA	
De veelground current per supply pin	ICCB	±50	ША	
Power dissipation	PD	200 (SSOP8)	mW	
	۳D	150 (CSON8)	11100	
Storage temperature	T _{stg}	–65 to 150	°C	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 2: Don't supply a voltage to V_{CCB} pin when V_{CCA} is in the OFF state.
- Note 3: Output in OFF state
- Note 4: High or Low stats. IOUT absolute maximum rating must be observed.
- Note 5: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CCA}	1.1 to 2.7	V
(Note 2) V _{CCB}	1.65 to 3.6	v
Input voltage (An, OE)	VIN	0 to 3.6	V
Output voltage	Voutb	0 to 3.6 (Note 3)	V
(Bn)	↓ 001B	0 to V _{CCB} (Note 4)	v
Output current		±12 (Note 5)	
(Bn)	IOUTB	±9 (Note 6)	mA
		±3 (Note 7)	
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.

Note 2: Don't use in $V_{CCA} > V_{CCB}$

Note 3: Output in OFF state

Note 4: High or low state

- Note 5: $V_{CCB} = 3.0$ to 3.6 V
- Note 6: $V_{CCB} = 2.3$ to 2.7 V
- Note 7: $V_{CCB} = 1.65$ to 1.95 V

Note 8: $V_{IN} = 0.8$ to 2.0 V, $V_{CCA} = 2.5$ V, $V_{CCB} = 3.0$ V

Electrical Characteristics

DC Characteristics (1.1 V \leq V_{CCA} \leq 2.7 V , 1.65 V \leq V_{CCB} \leq 3.6 V)

		Test Condition				Ta = -4	0~85°C																				
Characteristics	Symbol			V _{CCA} (V)	V _{CCB} (V)	Min	Max	Unit																			
				1.1≦V _{CCA} <1.4	1.65 to 3.6	0.65× V _{CCA}	_	V																			
H-level input voltage	VIHA	VIN		1.4≦V _{CCA} <1.65	2.3 to 3.6	0.65× V _{CCA}		V																			
				1.65≦V _{CCA} <2.3	2.3 to 3.6	0.65× V _{CCA}		V																			
				$2.3 \leq V_{CCA} \leq 2.7$	2.7 to 3.6	1.6	—	V																			
				1.1≦V _{CCA} <1.4	1.65 to 3.6		$\begin{array}{c} 0.30 \times \\ V_{CCA} \end{array}$	V																			
L-level input voltage	V _{ILA}	VIN		1.4≦V _{CCA} <1.65	2.3 to 3.6		$\begin{array}{c} 0.30 \times \\ V_{CCA} \end{array}$	V																			
				1.65≦V _{CCA} <2.3	2.3 to 3.6	_	$0.35 \times V_{CCA}$	V																			
				$2.3 \leq V_{CCA} \leq 2.7$	2.7 to 3.6	—	0.7	V																			
		$I_{OHB} = -100 \ \mu A$	1.1 to 2.7	1.65 to 3.6	V _{CCB} - 0.2																						
H-level output voltage	V _{OHB} A _n =	$A_{n} = V_{IH}$	$I_{OHB} = -3 \text{ mA}$	1.1 to 1.4	1.65 to 2.3	1.25	_	V																			
			$I_{OHB} = -9 \text{ mA}$	1.1 to 2.3	2.3 to 2.7	1.7	—																				
									$I_{OHB} = -12 \text{ mA}$	1.1 to 2.7	2.7 to 3.6	2.2	_														
			$I_{OLB}=100~\mu A$	1.1 to 2.7	1.65 to 3.6	—	0.2																				
L-level output voltage	V _{OLB}	A \/	∧ _\/	∧ _\/	A\/	∧ _\/	A	A _ \/	A	A _\/	A\/	∧ _\/u	Δ., – Μι	∧ _\/u	$\Delta_{m} = M_{m}$	$\Delta_{-} - M_{\rm H}$	$A_n = V_{IL}$	$\Delta = - M_{\rm H}$	$\Delta = - M_{\rm H}$	$\Delta = - M_{\rm H}$	$\Delta_{\rm m} = M_{\rm H}$	$I_{OLB} = 3 \text{ mA}$	1.1 to 1.4	1.65 to 2.3	_	0.3	V
	▲OLB	∽n – vi∟	$I_{OLB} = 9 \text{ mA}$	1.1 to 2.3	2.3 to 2.7	—	0.6	v																			
			$I_{OLB} = 12 \text{ mA}$	1.1 to 2.7	2.7 to 3.6	—	0.55																				
3-state output OFF state current	I _{OZB}	$A_n = V_{IHA}$ or $B_n = 0$ to 3.6		1.1 to 2.7	1.65 to 3.6	_	±2.0	μA																			
Input leakage current	I _{IN}	$V_{IN} = 0$ to 3.6	V	1.1~2.7	1.65 to 3.6	—	±1.0	μA																			
	IOFF1	$V_{IN},B_{II} = 0$ to	3.6 V	0	0	_	2.0																				
Power-off leakage current	I _{OFF2}	$\overline{OE} = V_{CCA}$		1.1 to 2.7	0	_	2.0	μA																			
	IOFF3	A_n , $B_n = 0$ to	3.6 V	1.1 to 2.7	OPEN		2.0																				
	ICCA	$V_{IN} = V_{CCA}$ or GND $V_{IN} = V_{CCA}$ or GND		1.1 to 2.7	1.65 to 3.6		2.0																				
	ICCB			1.1 to 2.7	1.65 to 3.6		2.0																				
Quiescent supply current	ICCA	$V_{CCA} < V_{IN} \leqq$	3.6 V	1.1 to 2.7	1.65 to 3.6	—	±2.0	μA																			
	Іссв	$V_{IN} = V_{CCA}$ $V_{CCB} \leq B_n \leq$	3.6 V	1.1 to 2.7	1.65 to 3.6		±2.0																				

AC Characteristics (Ta = -40 to 85°C, Input: $t_r = t_f = 2.0 \text{ ns}$)

 $V_{CCA} = 2.5 \pm 0.2$ V, $V_{CCB} = 3.3 \pm 0.3$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	6.8	
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	8.7	ns
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	3.9	
Output to output skew	^t osLH ^t osHL	(Note)	_	0.5	ns

Note: Parameter guaranteed by design.

 $(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$

$V_{CCA} = 1.8 \pm 0.15$ V, $V_{CCB} = 3.3 \pm 0.3$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	7.8	
3-state output enable time $(\overline{OE} \rightarrow Bn)$	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	10.7	ns
3-state output disable time $(\overline{OE} \rightarrow Bn)$	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	5.2	
Output to output skew	t _{osLH} t _{osHL}	(Note)		0.5	ns

Note: Parameter guaranteed by design.

 $(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$

$V_{CCA} = 1.5 \pm 0.1$ V, $V_{CCB} = 3.3 \pm 0.3$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	8.6	
3-state output enable time $(\overline{OE} \rightarrow Bn)$	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	14.3	ns
3-state output disable time $(\overline{OE} \rightarrow Bn)$	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	6.6	
Output to output skew	t _{osLH} t _{osHL}	(Note)		1.5	ns

Note: Parameter guaranteed by design.

 $(t_{\text{OSLH}} = |t_{\text{pLHm}} - t_{\text{pLHn}}|, t_{\text{OSHL}} = |t_{\text{pHLm}} - t_{\text{pHLn}}|)$

$V_{CCA} = 1.2 \pm 0.1$ V, $V_{CCB} = 3.3 \pm 0.3$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	22	
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	52	ns
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	18	
Output to output skew	t _{osLH} t _{osHL}	(Note)		1.5	ns

Note: Parameter guaranteed by design.

 $(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$

$V_{CCA} = 1.8 \pm 0.15$ V, $V_{CCB} = 2.5 \pm 0.2$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	9.5	
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	12.6	ns
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	5.1	
Output to output skew	t _{osLH} t _{osHL}	(Note)		0.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

$V_{CCA} = 1.5 \pm 0.1$ V, $V_{CCB} = 2.5 \pm 0.2$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	10.5	
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	15.4	ns
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	6.4	
Output to output skew	t _{osLH} t _{osHL}	(Note)		1.5	ns

Note: Parameter guaranteed by design.

 $(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$

$V_{CCA} = 1.2 \pm 0.1$ V, $V_{CCB} = 2.5 \pm 0.2$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	23	
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	54	ns
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	17	
Output to output skew	t _{osLH} t _{osHL}	(Note)		1.5	ns

Note: Parameter guaranteed by design.

 $(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$

$V_{CCA} = 1.2 \pm 0.1$ V, $V_{CCB} = 1.8 \pm 0.15$ V

Characteristics	Symbol	Test Condition	Min	Max	Unit
Propagation delay time $(An \rightarrow Bn)$	t _{pLH} t _{pHL}	Figure 1, Figure 2	1.0	30	
3-state output enable time ($\overline{OE} \rightarrow Bn$)	t _{pZL} t _{pZH}	Figure 1, Figure 3	1.0	55	ns
3-state output disable time ($\overline{OE} \rightarrow Bn$)	t _{pLZ} t _{pHZ}	Figure 1, Figure 3	1.0	17	
Output to output skew	t _{osLH} t _{osHL}	(Note)	_	1.5	ns

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$

Capacitive Characteristics (Ta = 25°C)

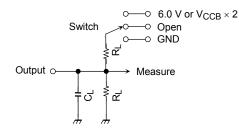
Characteristics		Symbol	Test Circuit			Тур.	Unit
Characteristics		Symbol		V _{CCA} (V)	$V_{CCB}(V)$		
Input capacitance		CIN	An, OE	2.5	3.3	7	pF
Output capacitance		C _{OUT}	Bn	2.5	3.3	8	pF
Power dissipation capacitance	e (Note)	CPDA	OE ="L"	2.5	3.3	3	- pF
			OE ="H"	2.5	3.3	0	
) C _{PDB}	OE ="L"	2.5	3.3	13	
			OE ="H"	2.5	3.3	0	

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 \text{ (per bit)}$

AC Test Circuit



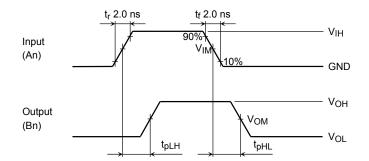
Parameter	Switch		
t _{pLH} , t _{pHL}	Open		
	6.0 V	@ $V_{CCB}=3.3\pm0.3V$	
t _{pLZ} , t _{pZL}	$V_{CCB} \times 2$	@ $V_{CCB}=2.5\pm0.2V$	
		@ V_{CCB} =1.8±0.15V	
t _{pHZ} , t _{pZH}	GND		

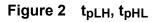
Symbol	V _{CCB} (output)		
	$\begin{array}{c} 3.3 \pm 0.3 \text{ V} \\ 2.5 \pm 0.2 \text{ V} \end{array}$	$1.8\pm0.15\;V$	
RL	500 Ω	1 kΩ	
CL	30 pF	30 pF	

Figure 1

<u>TOSHIBA</u>

AC Waveform





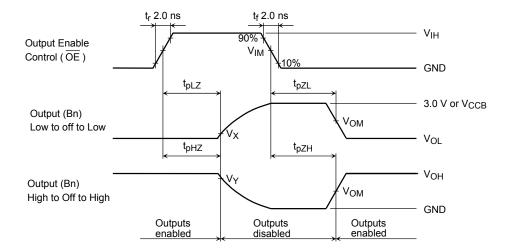


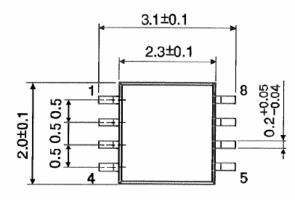
Figure 3 $t_{pLZ}, t_{pHZ}, t_{pZL}, t_{pZH}$

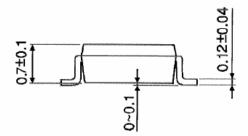
		V _{CCA} , V _{CCB}			
Symbol	$3.3\pm0.3~V$	$2.5\pm0.2\;V$	$1.5\pm0.1\;V$		
		$1.8\pm0.15\;V$	$1.2\pm0.1\;V$		
Input	VIH	-	V _{CCA}	V _{CCA}	
	VIM	-	V _{CCA} /2	V _{CCA} /2	
Output	V _{OM}	V _{OH} /2	V _{OH} /2	-	
	VX	V_{OL} + 0.3 V	V_{OL} + 0.15 V	-	
	VY	V _{OH} – 0.3 V	V _{OH} – 0.15 V	-	

Package Dimensions

SSOP8-P-0.50A

Unit : mm



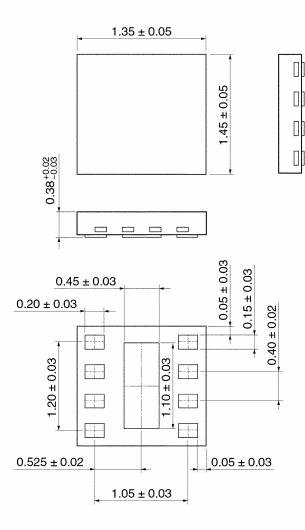


weight: 0.01 g (typ.)

Package Dimensions

CSON8-P-0.4

Unit: mm



Weight: 0.002 g (typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN

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